

Form PTO-1449

Applicant: Edward Edwardo Tapanes

Serial No.: 10/500,642

Filing Date: July 1, 2004

For: PERIMETER SECURITY SYSTEM AND PERIMETER MONITORING METHOD

Sheet 1 of 2

Confirmation No.: 2876

Att'y Docket No.: 13070.22

Group: 2874

INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANTU.S. Patent Documents

<u>Examiner Initial*</u>	<u>Document Number</u>	<u>Issue Date</u>	<u>Name</u>
/JMB/ 1	4,297,684	10/27/1981	Butter
2	4,931,771	06/05/1990	Kahn
3	4,990,769	02/05/1991	Hazan et al.
4	5,134,386	07/28/1992	Swanic
5	5,194,847	03/16/1993	Taylor et al.
/JMB/ 6	5,455,698	10/03/1995	Udd

Foreign Patent Documents

<u>Examiner Initial*</u>	<u>Document Number</u>	<u>Publication Date</u>	<u>Country or Patent Office</u>	<u>Translation</u>
/JMB/ 7	44 27 514 A1	02/08/1996	Germany	No
8	2000-48269	02/18/2000	Japan	Yes
9	WO 98/26388	06/18/1998	PCT	No
10	WO 00/37925	06/29/2000	PCT	No
11	WO 01/39148 A1	05/31/2001	PCT	No
12	WO 00/67400 A1	11/09/2000	PCT	No
/JMB/ 13	2 258 553 A	02/10/1993	United Kingdom	No

Other Documents

(including author, title, pertinent pages, etc.)

Examiner
Initial*

Examiner: /John Bedtelyon/

Date Considered: 08/20/2007

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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References Cited by Applicants

While the filing of Information Disclosure Statements is voluntary, the procedure is governed by the guidelines of Section 609 of the Manual of Patent Examining Procedure and 37 C.F.R. §§ 1.97 and 1.98. To be considered a proper Information Disclosure Statement, Form PTO-1449 shall be accompanied by a copy of each listed patent or publication or other item of information and a translation of the pertinent portions of foreign documents (if an existing translation is readily available to the applicant), an explanation of relevance of each reference not in the English language, and should be submitted in a timely manner as set out in MPEP Sec. 609.

Examiners will consider all citations submitted in conformance with 37 C.F.R. § 1.98 and MPEP Sec. 609 and place their initials adjacent the citations in the spaces provided on this form. Examiners will also initial citations not in conformance with the guidelines which may have been considered. A reference may be considered by the Examiner for any reason whether or not the citation is in full conformance with the guidelines. A line will be drawn through a citation if it is not in conformance with the guidelines AND has not been considered. A copy of the submitted form, as reviewed by the Examiner, will be returned to the applicant with the next communication. The original of the form will be entered into the application file.

Each citation initialed by the Examiner will be printed on the issued patent in the same manner as references cited by the Examiner on Form PTO-892.

The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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Examiner:

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